

Influencing factors of runway incursion risk and their interaction mechanism based on DEMATEL-ISM

Zhang P, Luo F.
Tehnicki Vjesnik
2017; 24(6):1853-1861

ARTICLE IDENTIFIERS

DOI: 10.17559/TV-20170928105858
PMID: unavailable
PMCID: not available

JOURNAL IDENTIFIERS

LCCN: 2018238301
pISSN: 1330-3651
eISSN: 1848-6339
OCLC ID: 962741129
CONS ID: not available
US National Library of Medicine ID: not available

This article was identified from a query of the SafetyLit database.